

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		09/494,801	GAUDETTE, ARTHUR L.	
Examiner		Art Unit		Page 1 of 1
Brian J. Detwiler		2173		

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NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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